

# 74LVCV2G66

Overvoltage tolerant bilateral switch

Rev. 02 — 3 July 2008

Product data sheet

## 1. General description

The 74LVCV2G66 is a low-power, low-voltage, high-speed Si-gate CMOS device.

The 74LVCV2G66 provides two single pole single throw analog or digital switches. Each switch includes an overvoltage tolerant input/output terminal (pin nZ), an output/input terminal (pin nY) and low-power active HIGH enable input (pin nE).

The overvoltage tolerant switch terminals allow the switching of signals in excess of  $V_{CC}$ . The low-power enable input eliminates the necessity of using current limiting resistors in portable applications when using control logic signals much lower than  $V_{CC}$ . These inputs are also overvoltage tolerant.

## 2. Features

- Wide supply voltage range from 2.3 V to 5.5 V
- Ultra low-power operation
- Very low ON resistance:
  - ◆ 8.0  $\Omega$  (typical) at  $V_{CC} = 2.7$  V
  - ◆ 7.5  $\Omega$  (typical) at  $V_{CC} = 3.3$  V
  - ◆ 7.3  $\Omega$  (typical) at  $V_{CC} = 5.0$  V.
- 5 V tolerant input for interfacing with 5 V logic
- High noise immunity
- Switch handling capability of 32 mA
- CMOS low-power consumption
- Latch-up performance exceeds 250 mA
- Incorporates overvoltage tolerant analog switch technology
- Switch accepts voltages up to 5.5 V independent of  $V_{CC}$
- Multiple package options
- Specified from  $-40$  °C to  $+85$  °C and  $-40$  °C to  $+125$  °C

### 3. Ordering information

**Table 1. Ordering information**

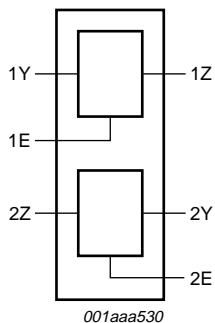
Type number	Package	Temperature range	Name	Description	Version
74LVCV2G66DP	TSSOP8	-40 °C to +125 °C		plastic thin shrink small outline package; 8 leads; body width 3 mm; lead length 0.5 mm	SOT505-2
74LVCV2G66DC	VSSOP8	-40 °C to +125 °C		plastic very thin shrink small outline package; 8 leads; body width 2.3 mm	SOT765-1
74LVCV2G66GD	XSON8U	-40 °C to +125 °C		plastic extremely thin small outline package; no leads; 8 terminals; UTLP based; body 3 × 2 × 0.5 mm	SOT996-2

### 4. Marking

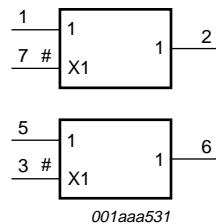
**Table 2. Marking codes**

Type number	Marking code
74LVCV2G66DP	Y66
74LVCV2G66DC	Y66
74LVCV2G66GD	Y66

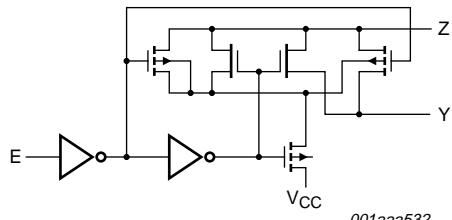
### 5. Functional diagram



**Fig 1. Logic symbol**



**Fig 2. IEC logic symbol**



**Fig 3. Logic diagram (one switch)**

## 6. Pinning information

### 6.1 Pinning

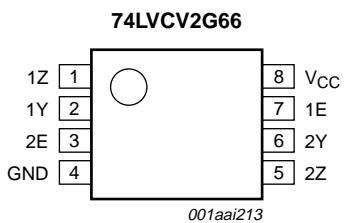


Fig 4. Pin configuration SOT505-2 (TSSOP8) and SOT765-1 (VSSOP8)

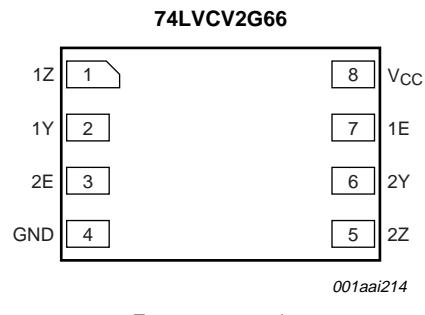


Fig 5. Pin configuration SOT996-2 (XSON8U)

### 6.2 Pin description

Table 3. Pin description

Symbol	Pin	Description
1Y, 2Y	2, 6	independent input or output
1Z, 2Z	1, 5	independent input or output (overvoltage tolerance)
GND	4	ground (0 V)
1E, 2E	7, 3	enable input (active HIGH)
V <sub>CC</sub>	8	supply voltage

## 7. Functional description

Table 4: Function table<sup>[1]</sup>

Input nE	Switch
L	OFF-state
H	ON-state

[1] H = HIGH voltage level; L = LOW voltage level.

## 8. Limiting values

Table 5: Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+6.5	V
V <sub>I</sub>	input voltage		<sup>[1]</sup> -0.5	+6.5	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < -0.5 V or V <sub>I</sub> > 6.5 V	-	-50	mA
I <sub>SK</sub>	switch clamping current	V <sub>I</sub> < -0.5 V or V <sub>I</sub> > 6.5 V	-	±50	mA

**Table 5: Limiting values ...continued**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>SW</sub>	switch voltage	enable and disable mode	-0.5	+6.5	V
I <sub>SW</sub>	switch current	V <sub>SW</sub> > -0.5 V or V <sub>SW</sub> < 6.5 V	-	±50	mA
I <sub>CC</sub>	supply current		-	100	mA
I <sub>GND</sub>	ground current		-100	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	power dissipation	T <sub>amb</sub> = -40 °C to +125 °C	[2]	-	250 mW

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] For TSSOP8 package: above 55 °C the value of P<sub>tot</sub> derates linearly with 2.5 mW/K.For VSSOP8 package: above 110 °C the value of P<sub>tot</sub> derates linearly with 8 mW/K.For XSON8U package: above 45 °C the value of P<sub>tot</sub> derates linearly with 2.4 mW/K.

## 9. Recommended operating conditions

**Table 6: Recommended operating conditions**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V <sub>CC</sub>	supply voltage		2.3	-	5.5	V
V <sub>I</sub>	input voltage		0	-	5.5	V
V <sub>SW</sub>	switch voltage	enable and disable mode	[1] 0	-	5.5	V
T <sub>amb</sub>	operating ambient temperature		-40	-	+125	°C
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 2.3 V to 2.7 V	[2] -	-	20	ns/V
		V <sub>CC</sub> = 2.7 V to 5.5 V	[2] -	-	10	ns/V

[1] To avoid sinking GND current from terminal nZ when switch current flows in terminal nY, the voltage drop across the bidirectional switch must not exceed 0.4 V. If the switch current flows into terminal nZ, no GND current will flow from terminal nY. In this case, there is no limit for the voltage drop across the switch.

[2] Applies to control signal levels.

## 10. Static characteristics

**Table 7. Static characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C			Unit
			Min	Typ [1]	Max	Min	Max		
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V	0.6V <sub>CC</sub>	-	-	0.6V <sub>CC</sub>	-	-	V
		V <sub>CC</sub> = 3.0 V to 3.6 V	2.0	-	-	2.0	-	-	V
		V <sub>CC</sub> = 4.5 V to 5.5 V	0.55V <sub>CC</sub>	-	-	0.55V <sub>CC</sub>	-	-	V
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V	-	-	0.1V <sub>CC</sub>	-	0.1V <sub>CC</sub>	-	V
		V <sub>CC</sub> = 3.0 V to 3.6 V	-	-	0.5	-	0.5	-	V
		V <sub>CC</sub> = 4.5 V to 5.5 V	-	-	0.15V <sub>CC</sub>	-	0.15V <sub>CC</sub>	-	V
I <sub>I</sub>	input leakage current	pin nE; V <sub>I</sub> = 5.5 V or GND; V <sub>CC</sub> = 0 V to 5.5 V	[2]	-	±0.1	±5	-	±5	μA

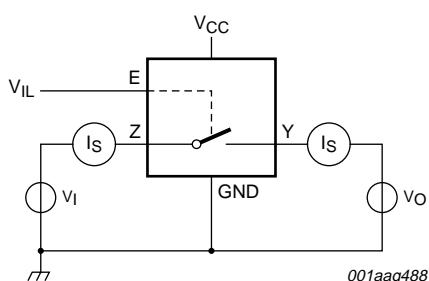
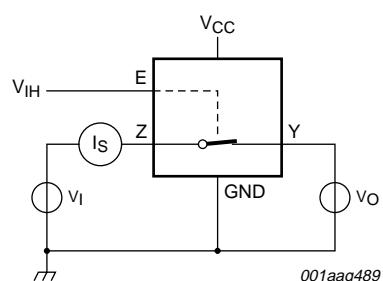
**Table 7. Static characteristics ...continued**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C			Unit
			Min	Typ <sup>[1]</sup>	Max	Min	Max		
I <sub>S(OFF)</sub>	OFF-state leakage current	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>CC</sub> = 2.3 V to 5.5 V; see <a href="#">Figure 6</a>	[2][3]	-	±0.1	±10	-	±10	µA
I <sub>S(ON)</sub>	ON-state leakage current	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; V <sub>CC</sub> = 2.3 V to 5.5 V; see <a href="#">Figure 7</a>	[2][3]	-	±0.1	±10	-	±10	µA
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>SW</sub> = GND or V <sub>CC</sub> ; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 2.3 V to 5.5 V	[2]	-	0.1	10	-	40	µA
ΔI <sub>CC</sub>	additional supply current	pin nE; V <sub>I</sub> = V <sub>CC</sub> - 0.6 V; V <sub>SW</sub> = GND or V <sub>CC</sub> ; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 3.0 V to 5.5 V	[2]	-	0.1	5	-	50	µA
C <sub>I</sub>	input capacitance			-	2.5	-	-	-	pF
C <sub>S(OFF)</sub>	OFF-state capacitance			-	8.0	-	-	-	pF
C <sub>S(ON)</sub>	ON-state capacitance			-	16	-	-	-	pF

[1] All typical values are measured at T<sub>amb</sub> = 25 °C.[2] These typical values are measured at V<sub>CC</sub> = 3.3 V.[3] For overvoltage signals (V<sub>SW</sub> > V<sub>CC</sub>) the condition V<sub>Y</sub> < V<sub>Z</sub> must be observed.

## 10.1 Test circuits

V<sub>I</sub> = GND and V<sub>O</sub> = GND or 5.5 V.**Fig 6. Test circuit for measuring OFF-state leakage current**V<sub>I</sub> = 5.5 V or GND and V<sub>O</sub> = open circuit.**Fig 7. Test circuit for measuring ON-state leakage current**

## 10.2 ON resistance

**Table 8. Resistance  $R_{ON}$**

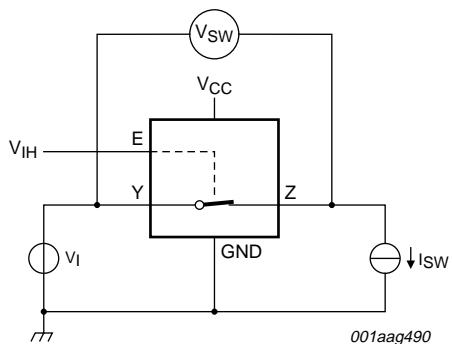
At recommended operating conditions; voltages are referenced to GND (ground 0 V); for graphs see [Figure 9](#) and [Figure 10](#).

Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C			Unit
			Min	Typ <sup>[1]</sup>	Max	Min	Max		
$R_{ON(peak)}$	ON resistance (peak)	$V_{SW} = \text{GND to } V_{CC}; V_I = V_{IH}$ ; see <a href="#">Figure 8</a>							
		$I_{SW} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	13	30	-	30	$\Omega$	
		$I_{SW} = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	10	25	-	25	$\Omega$	
		$I_{SW} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	8.3	20	-	20	$\Omega$	
$R_{ON(rail)}$	ON resistance (rail)	$V_{SW} = \text{GND}; V_I = V_{IH}$ ; see <a href="#">Figure 8</a>							
		$I_{SW} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	8.5	20	-	20	$\Omega$	
		$I_{SW} = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	8.0	18	-	18	$\Omega$	
		$I_{SW} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	7.5	15	-	15	$\Omega$	
		$I_{SW} = 32 \text{ mA}; V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	-	7.3	10	-	10	$\Omega$	
		$V_{SW} = V_{CC}; V_I = V_{IH}$							
		$I_{SW} = 8 \text{ mA}; V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	8.5	20	-	20	$\Omega$	
		$I_{SW} = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	7.2	18	-	18	$\Omega$	
		$I_{SW} = 24 \text{ mA}; V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	6.5	15	-	15	$\Omega$	
		$I_{SW} = 32 \text{ mA}; V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	-	5.7	10	-	10	$\Omega$	
$R_{ON(flat)}$	ON resistance (flatness)	$V_{SW} = \text{GND to } V_{CC}; V_I = V_{IH}$	[2]						
		$I_{SW} = 8 \text{ mA}; V_{CC} = 2.5 \text{ V}$	-	17	-	-	-	$\Omega$	
		$I_{SW} = 12 \text{ mA}; V_{CC} = 2.7 \text{ V}$	-	10	-	-	-	$\Omega$	
		$I_{SW} = 24 \text{ mA}; V_{CC} = 3.3 \text{ V}$	-	5	-	-	-	$\Omega$	
		$I_{SW} = 32 \text{ mA}; V_{CC} = 5.0 \text{ V}$	-	3	-	-	-	$\Omega$	

[1] All typical values are measured at  $T_{amb} = 25 \text{ }^{\circ}\text{C}$  and nominal  $V_{CC}$ .

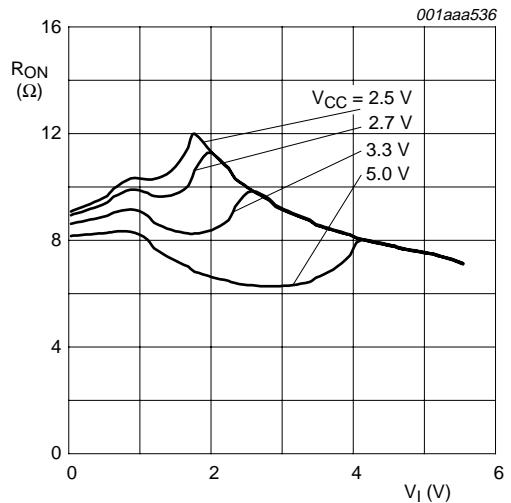
[2] Flatness is defined as the difference between the maximum and minimum value of ON resistance measured at identical  $V_{CC}$  and temperature.

### 10.3 ON resistance test circuit and graphs



$V_I = \text{GND to } 5.5 \text{ V}$ ;  $R_{ON} = V_{SW} / I_{SW}$ .

**Fig 8. Test circuit for measuring ON resistance**



$V_I = \text{GND to } 5.5 \text{ V}$ ;  $T_{amb} = 25^\circ\text{C}$ .

**Fig 9. Typical ON resistance as a function of input voltage**

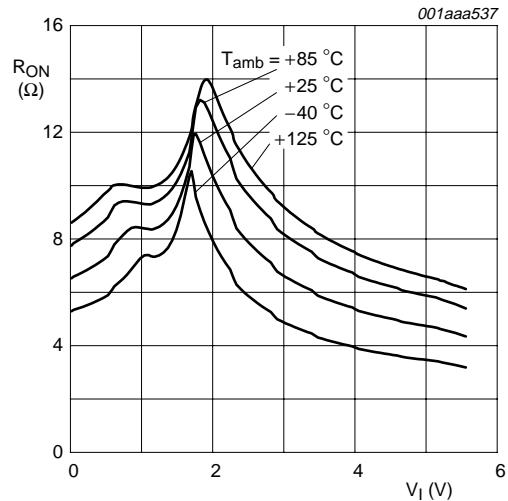
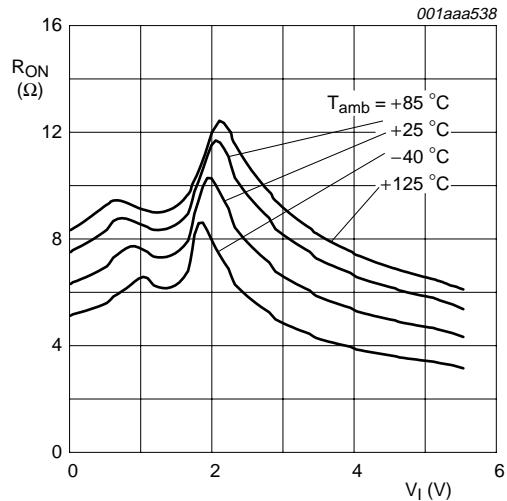
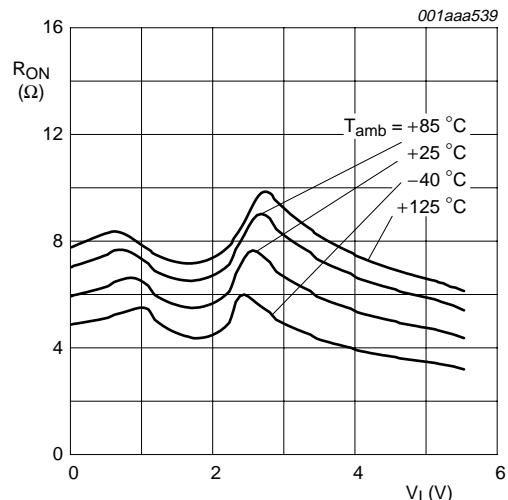
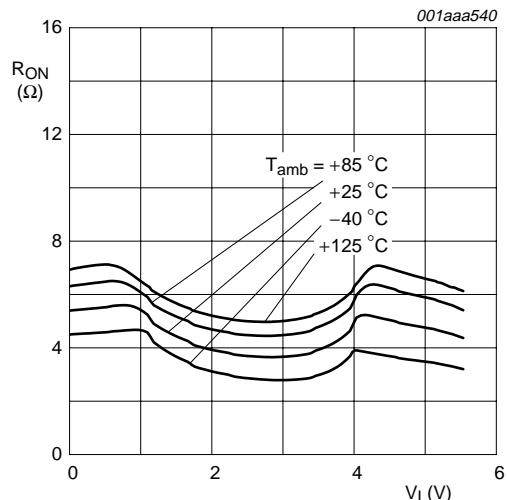
a.  $V_{CC} = 2.5\text{ V}$ b.  $V_{CC} = 2.7\text{ V}$ c.  $V_{CC} = 3.3\text{ V}$ d.  $V_{CC} = 5.0\text{ V}$ 

Fig 10. ON resistance as a function of input voltage at various supply voltages

## 11. Dynamic characteristics

**Table 9. Dynamic characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V); for test circuit see [Figure 13](#).

Symbol	Parameter	Conditions	−40 °C to +85 °C			−40 °C to +125 °C		Unit
			Min	Typ <sup>[1]</sup>	Max	Min	Max	
$t_{pd}$	propagation delay	nY to nZ or nZ to nY; see <a href="#">Figure 11</a>	<a href="#">[2][3]</a>					
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	-	0.4	1.2	-	2.0	ns
		$V_{CC} = 2.7 \text{ V}$	-	0.4	1.0	-	1.5	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	-	0.3	0.8	-	1.5	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	-	0.2	0.6	-	1.0	ns
$t_{en}$	enable time	nE to nY or nZ; see <a href="#">Figure 12</a>	<a href="#">[4]</a>					
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.0	4.7	12	1.0	15	ns
		$V_{CC} = 2.7 \text{ V}$	1.0	4.4	8.5	1.0	11	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	1.0	3.8	7.5	1.0	9.5	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	1.0	2.7	5.0	1.0	6.5	ns
$t_{dis}$	disable time	nE to nY or nZ; see <a href="#">Figure 12</a>	<a href="#">[5]</a>					
		$V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$	1.0	6.0	16	1.0	20	ns
		$V_{CC} = 2.7 \text{ V}$	1.0	7.9	15	1.0	19	ns
		$V_{CC} = 3.0 \text{ V to } 3.6 \text{ V}$	1.0	6.5	13.5	1.0	17	ns
		$V_{CC} = 4.5 \text{ V to } 5.5 \text{ V}$	1.0	4.4	9.0	1.0	11.5	ns
$C_{PD}$	power dissipation capacitance	$C_L = 50 \text{ pF}; f_i = 10 \text{ MHz};$ $V_I = \text{GND to } 5.5 \text{ V}$	<a href="#">[6]</a>					
		$V_{CC} = 2.5 \text{ V}$	-	9.7	-	-	-	pF
		$V_{CC} = 3.3 \text{ V}$	-	10.3	-	-	-	pF
		$V_{CC} = 5.0 \text{ V}$	-	11.3	-	-	-	pF

[1] Typical values are measured at  $T_{amb} = 25 \text{ °C}$  and nominal  $V_{CC}$ .

[2]  $t_{pd}$  is the same as  $t_{PLH}$  and  $t_{PHL}$ .

[3] Propagation delay is the calculated RC time constant of the typical ON resistance of the switch and the specified capacitance when driven by an ideal voltage source (zero output impedance).

[4]  $t_{en}$  is the same as  $t_{PZH}$  and  $t_{PZL}$ .

[5]  $t_{dis}$  is the same as  $t_{PLZ}$  and  $t_{PHZ}$ .

[6]  $C_{PD}$  is used to determine the dynamic power dissipation ( $P_D$  in  $\mu\text{W}$ ).

$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma \{(C_L + C_{S(ON)}) \times V_{CC}^2 \times f_o\}$  where:

$f_i$  = input frequency in MHz;

$f_o$  = output frequency in MHz;

$C_L$  = output load capacitance in pF;

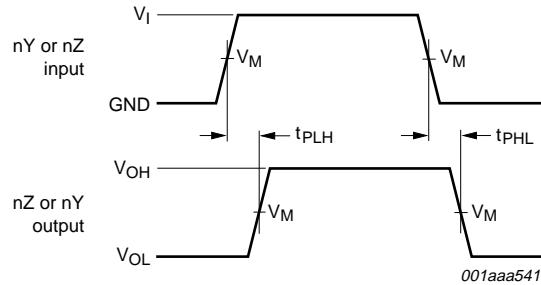
$C_{S(ON)}$  = maximum ON-state switch capacitance in pF;

$V_{CC}$  = supply voltage in V;

N = number of inputs switching;

$\Sigma \{(C_L + C_{S(ON)}) \times V_{CC}^2 \times f_o\}$  = sum of the outputs.

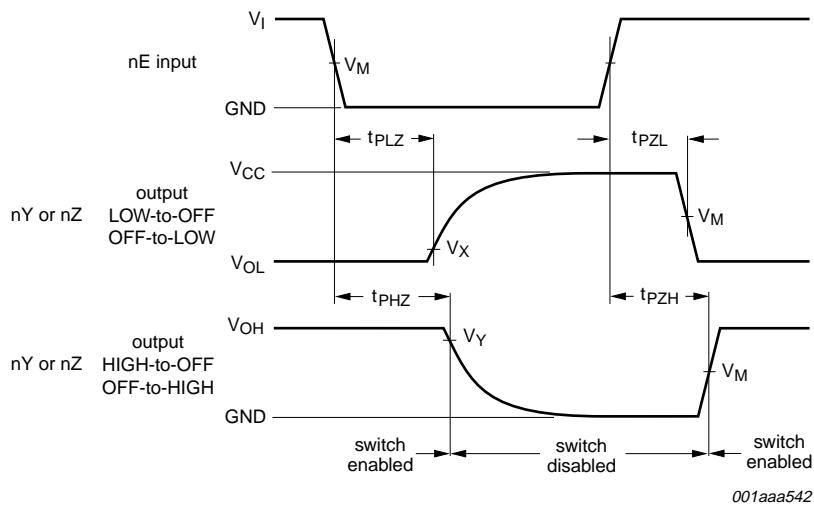
### 11.1 Waveforms and test circuit



Measurement points are given in [Table 10](#).

Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 11. Input (nY or nZ) to output (nZ or nY) propagation delays**



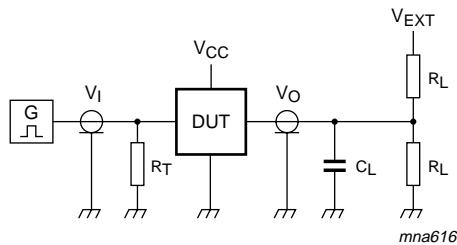
Measurement points are given in [Table 10](#).

Logic levels:  $V_{OL}$  and  $V_{OH}$  are typical output voltage levels that occur with the output load.

**Fig 12. Enable and disable times**

**Table 10. Measurement points**

Supply voltage	Input	Output		
$V_{CC}$	$V_M$	$V_M$	$V_X$	$V_Y$
2.3 V to 2.7 V	0.5 $V_{CC}$	0.5 $V_{CC}$	$V_{OL} + 0.1V_{CC}$	$V_{OH} - 0.1V_{CC}$
2.7 V	1.5 V	1.5 V	$V_{OL} + 0.3$ V	$V_{OH} - 0.3$ V
3.0 V to 3.6 V	1.5 V	1.5 V	$V_{OL} + 0.3$ V	$V_{OH} - 0.3$ V
4.5 V to 5.5 V	0.5 $V_{CC}$	0.5 $V_{CC}$	$V_{OL} + 0.3$ V	$V_{OH} - 0.3$ V



Test data is given in [Table 11](#).

Definitions test circuit:

$R_T$  = Termination resistance should be equal to output impedance  $Z_0$  of the pulse generator.

$C_L$  = Load capacitance including jig and probe capacitance.

$R_L$  = Load resistance.

$V_{EXT}$  = External voltage for measuring switching times.

**Fig 13. Load circuit for measuring switching times**

**Table 11. Test data**

Supply voltage	Input		Load		$V_{EXT}$		
$V_{CC}$	$V_I$	$t_r, t_f$	$C_L$	$R_L$	$t_{PLH}, t_{PHL}$	$t_{PZH}, t_{PHZ}$	$t_{PZL}, t_{PLZ}$
2.3 V to 2.7 V	$V_{CC}$	$\leq 2.0$ ns	30 pF	500 $\Omega$	open	GND	$2V_{CC}$
2.7 V	2.7 V	$\leq 2.5$ ns	50 pF	500 $\Omega$	open	GND	6.0 V
3.0 V to 3.6 V	2.7 V	$\leq 2.5$ ns	50 pF	500 $\Omega$	open	GND	6.0 V
4.5 V to 5.5 V	$V_{CC}$	$\leq 2.5$ ns	50 pF	500 $\Omega$	open	GND	$2V_{CC}$

## 11.2 Additional dynamic characteristics

**Table 12. Additional dynamic characteristics**

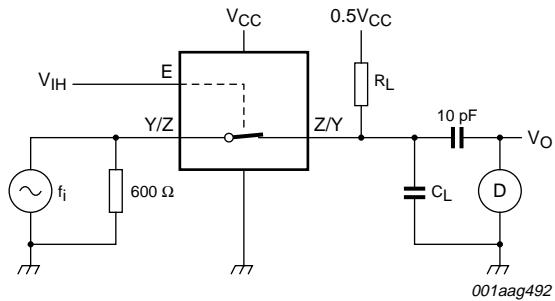
At recommended operating conditions; voltages are referenced to GND (ground = 0 V);  $T_{amb} = 25^\circ C$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
THD	total harmonic distortion	$f_i = 1$ kHz; $R_L = 10$ k $\Omega$ ; $C_L = 50$ pF; see <a href="#">Figure 14</a>				
		$V_{CC} = 2.3$ V	-	0.42	-	%
		$V_{CC} = 3.0$ V	-	0.36	-	%
		$V_{CC} = 4.5$ V	-	0.47	-	%
		$f_i = 10$ kHz; $R_L = 10$ k $\Omega$ ; $C_L = 50$ pF; see <a href="#">Figure 14</a>				
		$V_{CC} = 2.3$ V	-	0.11	-	%
		$V_{CC} = 3.0$ V	-	0.07	-	%
		$V_{CC} = 4.5$ V	-	0.01	-	%

**Table 12. Additional dynamic characteristics ...continued**At recommended operating conditions; voltages are referenced to GND (ground = 0 V);  $T_{amb} = 25^\circ C$ .

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$f_{(-3dB)}$	–3 dB frequency response	$R_L = 600 \Omega$ ; $C_L = 50 \text{ pF}$ ; see <a href="#">Figure 15</a>				
		$V_{CC} = 2.3 \text{ V}$	-	160	-	MHz
		$V_{CC} = 3.0 \text{ V}$	-	200	-	MHz
		$V_{CC} = 4.5 \text{ V}$	-	210	-	MHz
		$R_L = 50 \Omega$ ; $C_L = 5 \text{ pF}$ ; see <a href="#">Figure 15</a>				
		$V_{CC} = 2.3 \text{ V}$	-	180	-	MHz
		$V_{CC} = 3.0 \text{ V}$	-	180	-	MHz
		$V_{CC} = 4.5 \text{ V}$	-	180	-	MHz
$\alpha_{iso}$	isolation (OFF-state)	$R_L = 600 \Omega$ ; $C_L = 50 \text{ pF}$ ; $f_i = 1 \text{ MHz}$ ; see <a href="#">Figure 16</a>				
		$V_{CC} = 2.3 \text{ V}$	-	-65	-	dB
		$V_{CC} = 3.0 \text{ V}$	-	-65	-	dB
		$V_{CC} = 4.5 \text{ V}$	-	-62	-	dB
		$R_L = 50 \Omega$ ; $C_L = 5 \text{ pF}$ ; $f_i = 1 \text{ MHz}$ ; see <a href="#">Figure 16</a>				
		$V_{CC} = 2.3 \text{ V}$	-	-37	-	dB
		$V_{CC} = 3.0 \text{ V}$	-	-36	-	dB
		$V_{CC} = 4.5 \text{ V}$	-	-36	-	dB
$V_{ct}$	crosstalk voltage	between digital inputs and switch; $R_L = 600 \Omega$ ; $C_L = 50 \text{ pF}$ ; $f_i = 1 \text{ MHz}$ ; $t_r = t_f = 2 \text{ ns}$ ; see <a href="#">Figure 17</a>				
		$V_{CC} = 2.3 \text{ V}$	-	91	-	mV
		$V_{CC} = 3.0 \text{ V}$	-	119	-	mV
		$V_{CC} = 4.5 \text{ V}$	-	205	-	mV
Xtalk	crosstalk	between switches; $R_L = 600 \Omega$ ; $C_L = 50 \text{ pF}$ ; $f_i = 1 \text{ MHz}$ ; see <a href="#">Figure 18</a>				
		$V_{CC} = 2.3 \text{ V}$	-	-56	-	dB
		$V_{CC} = 3.0 \text{ V}$	-	-55	-	dB
		$V_{CC} = 4.5 \text{ V}$	-	-55	-	dB
		between switches; $R_L = 50 \Omega$ ; $C_L = 5 \text{ pF}$ ; $f_i = 1 \text{ MHz}$ ; see <a href="#">Figure 18</a>				
		$V_{CC} = 2.3 \text{ V}$	-	-29	-	dB
		$V_{CC} = 3.0 \text{ V}$	-	-28	-	dB
		$V_{CC} = 4.5 \text{ V}$	-	-28	-	dB
$Q_{inj}$	charge injection	$C_L = 0.1 \text{ nF}$ ; $V_{gen} = 0 \text{ V}$ ; $R_{gen} = 0 \Omega$ ; $f_i = 1 \text{ MHz}$ ; $R_L = 1 \text{ M}\Omega$ ; see <a href="#">Figure 19</a>				
		$V_{CC} = 2.5 \text{ V}$	-	< 0.003	-	pC
		$V_{CC} = 3.3 \text{ V}$	-	0.003	-	pC
		$V_{CC} = 4.5 \text{ V}$	-	0.0035	-	pC
		$V_{CC} = 5.5 \text{ V}$	-	0.0035	-	pC

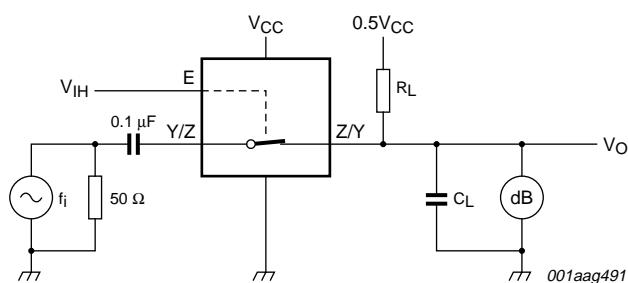
### 11.3 Test circuits


**Test conditions:**
 $V_{CC} = 2.3\text{ V}; V_i = 2\text{ V}$  (p-p).

 $V_{CC} = 3\text{ V}; V_i = 2.5\text{ V}$  (p-p).

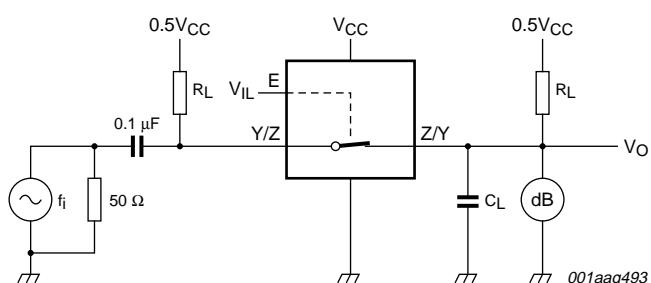
 $V_{CC} = 4.5\text{ V}; V_i = 4\text{ V}$  (p-p).

**Fig 14.** Test circuit for measuring total harmonic distortion



Adjust  $f_i$  voltage to obtain 0 dBm level at output. Increase  $f_i$  frequency until dB meter reads -3 dB.

**Fig 15.** Test circuit for measuring the frequency response when switch is in ON-state



Adjust  $f_i$  voltage to obtain 0 dBm level at input.

**Fig 16.** Test circuit for measuring isolation (OFF-state)

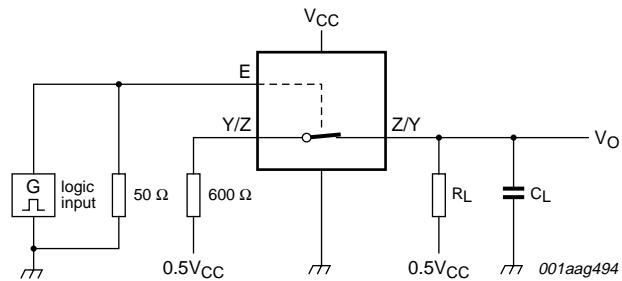
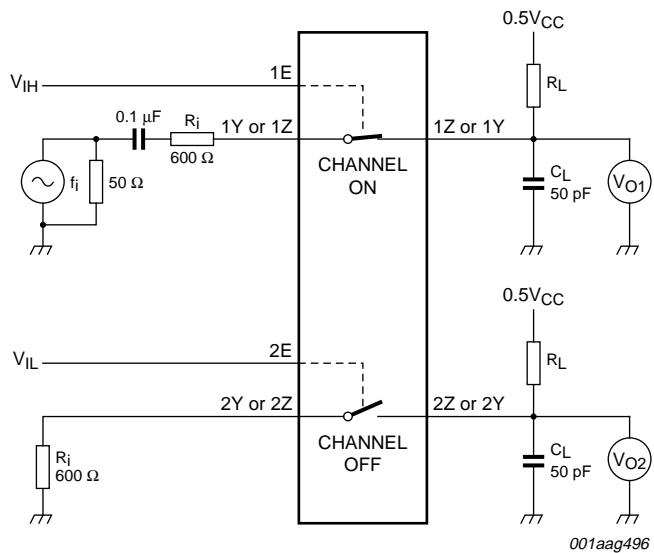
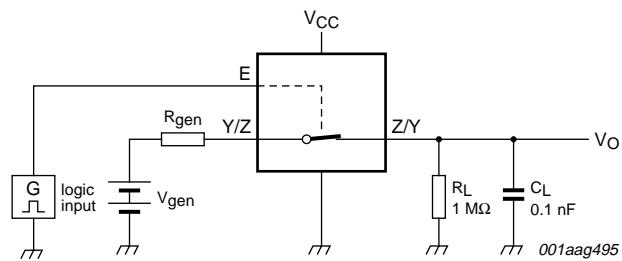


Fig 17. Test circuit for measuring crosstalk voltage (between digital inputs and switch)

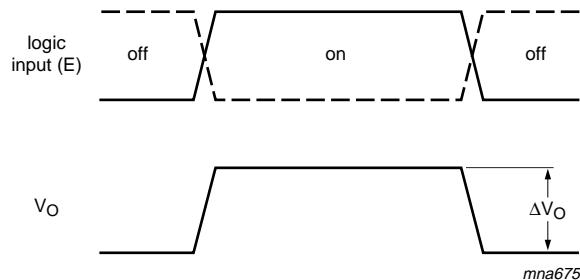


$20 \log_{10} (V_{O2} / V_{O1})$  or  $20 \log_{10} (V_{O1} / V_{O2})$ .

Fig 18. Test circuit for measuring crosstalk between switches



a. Test circuit



b. Input and output pulse definitions

$$Q_{\text{inj}} = \Delta V_O \times C_L$$

$\Delta V_O$  = output voltage variation.

$R_{\text{gen}}$  = generator resistance.

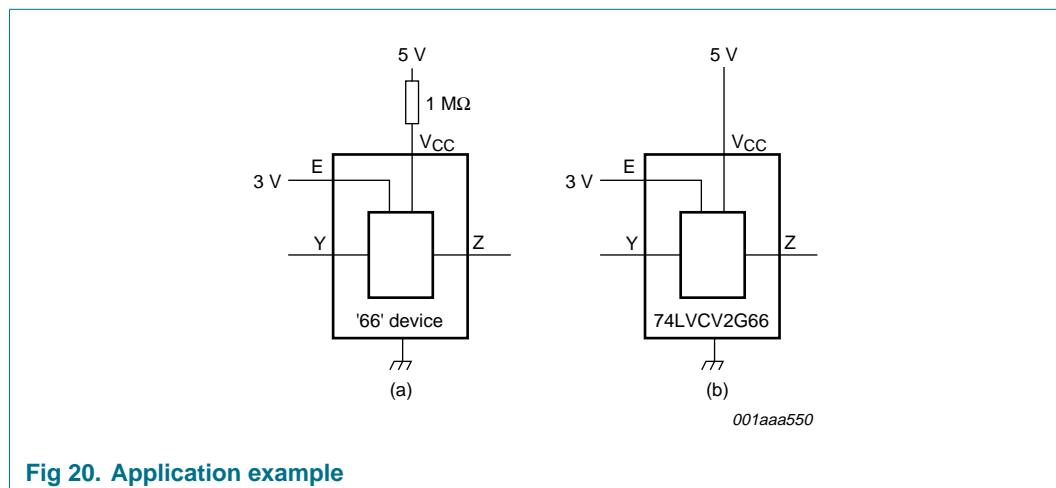
$V_{\text{gen}}$  = generator voltage.

Fig 19. Test circuit for measuring charge injection

## 12. Application information

Use the 74LVCV2G66 to reduce component count and footprint in low-power portable applications.

Typical '66' devices do not have low-power enable inputs causing a high  $\Delta I_{CC}$ . To reduce power consumption in portable (battery) applications, a current limiting resistor is used. (see [Figure 20a](#)). The low-power enable inputs of the 74LVCV2G66 have much lower  $\Delta I_{CC}$ , eliminating the necessity of the current limiting resistor (see [Figure 20b](#)).



**Fig 20. Application example**

## 13. Package outline

TSSOP8: plastic thin shrink small outline package; 8 leads; body width 3 mm; lead length 0.5 mm SOT505-2

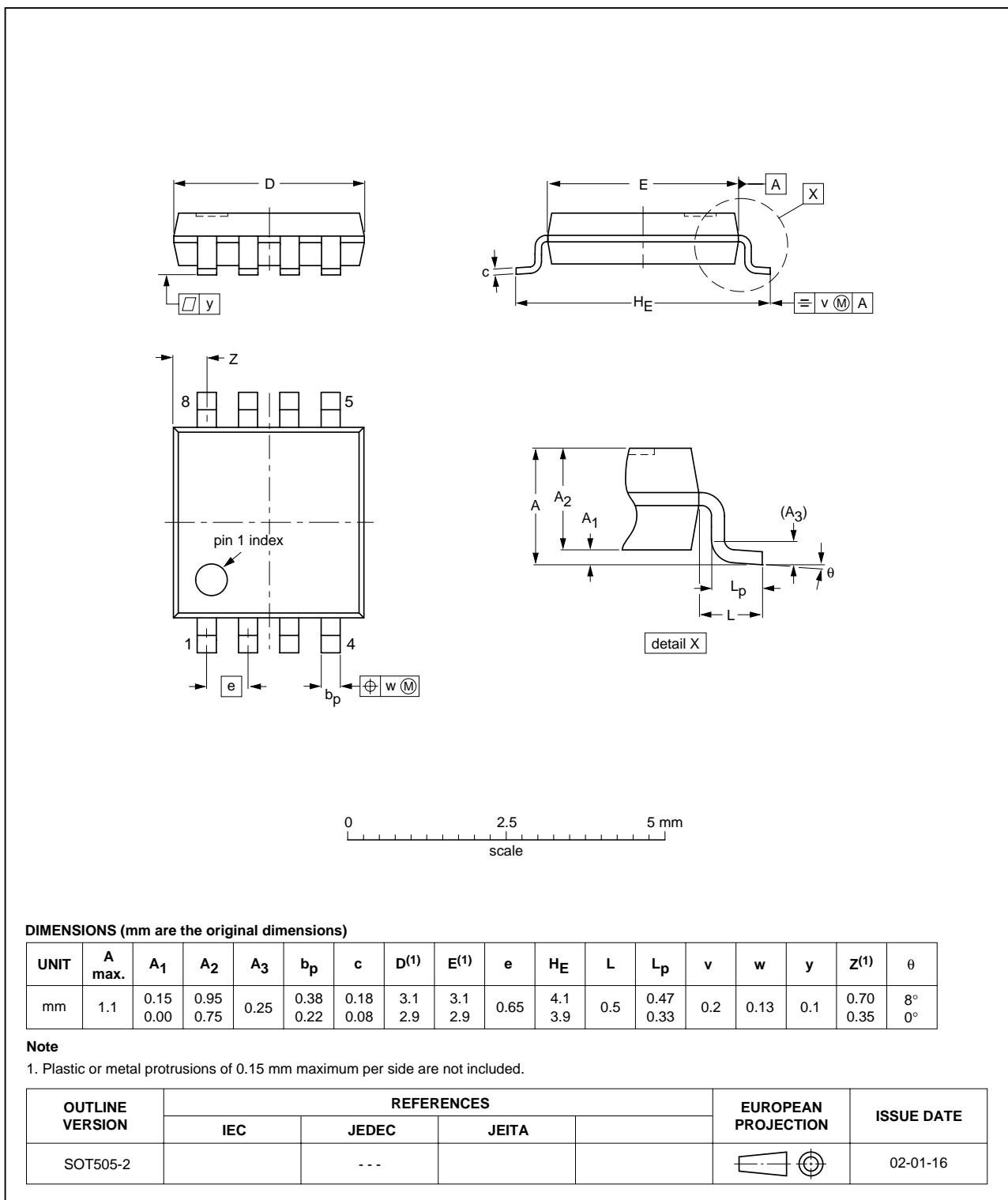


Fig 21. Package outline SOT505-2 (TSSOP8)

VSSOP8: plastic very thin shrink small outline package; 8 leads; body width 2.3 mm

SOT765-1

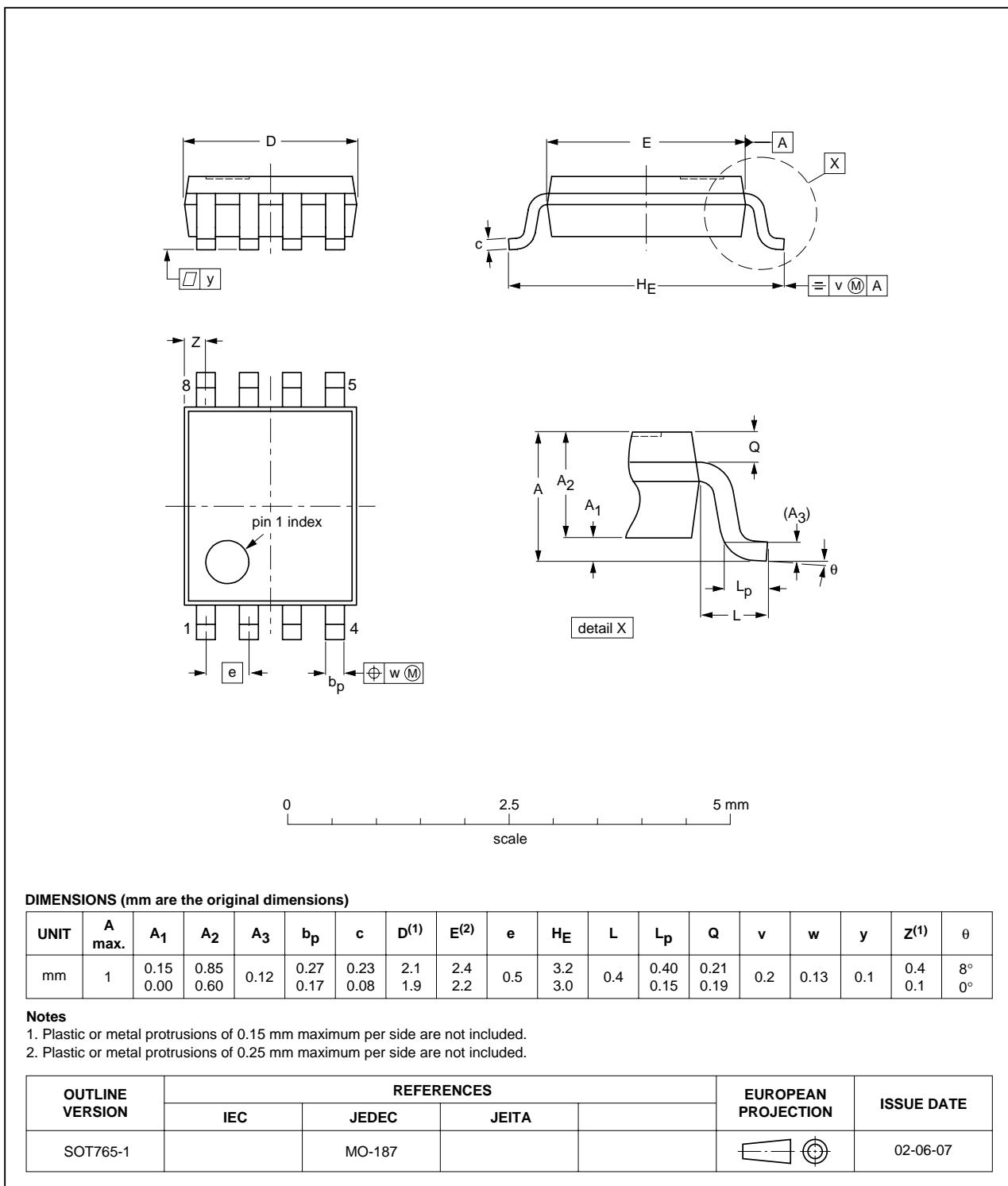


Fig 22. Package outline SOT765-1 (VSSOP8)

XSON8U: plastic extremely thin small outline package; no leads;  
8 terminals; UTLP based; body  $3 \times 2 \times 0.5$  mm

SOT996-2

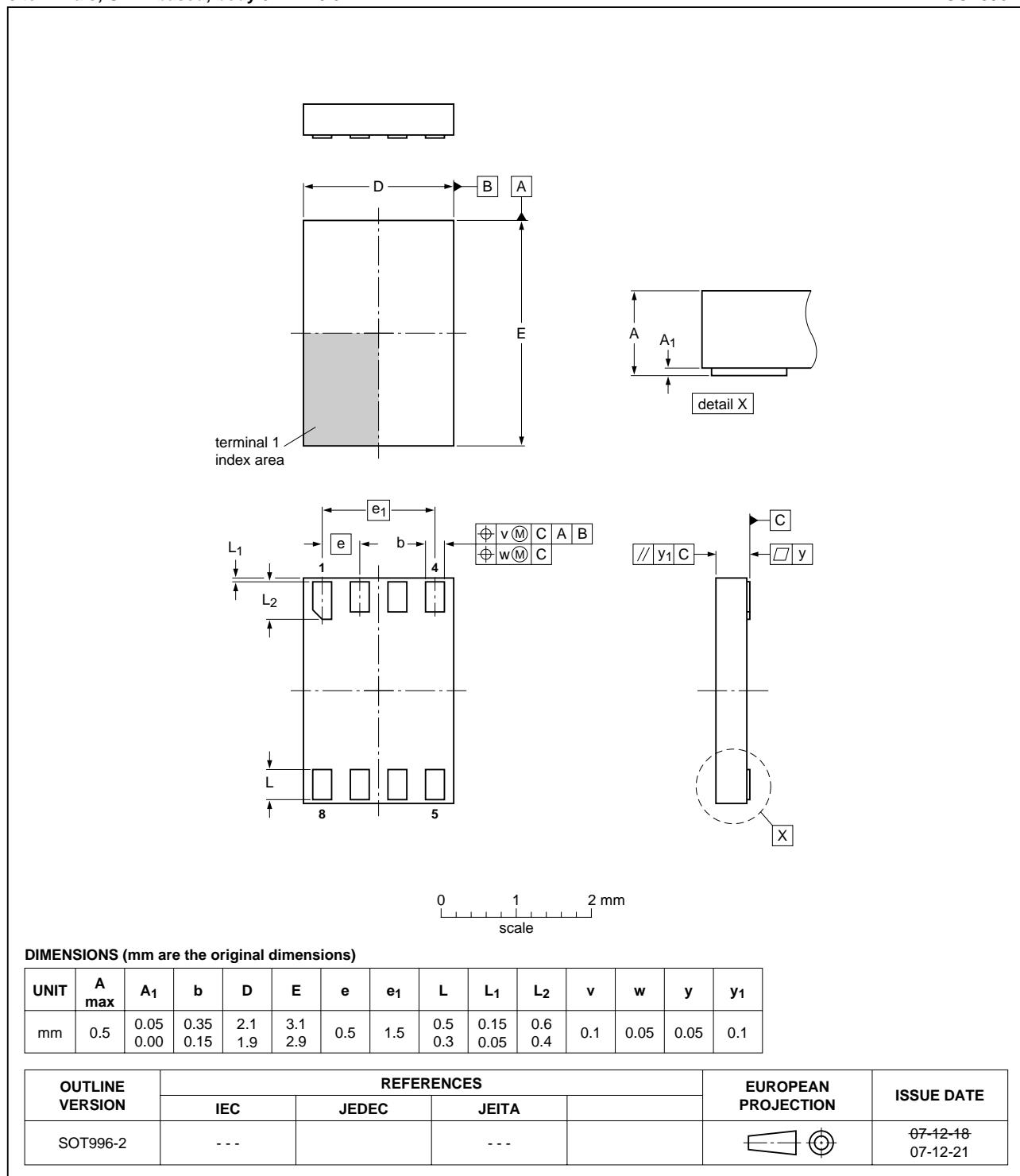


Fig 23. Package outline SOT996-2 (XSON8U)

## 14. Abbreviations

**Table 13. Abbreviations**

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test

## 15. Revision history

**Table 14: Revision history**

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LVCV2G66_2	20080703	Product data sheet	-	74LVCV2G66_1
Modifications:			<ul style="list-style-type: none"><li>The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li><li>Legal texts have been adapted to the new company name where appropriate.</li><li>Added type number 74LVCV2G66GD (XSON8U package).</li></ul>	
74LVCV2G66_1	20040402	Product data sheet	-	-

## 16. Legal information

### 16.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

[3] The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL <http://www.nxp.com>.

### 16.2 Definitions

**Draft** — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

**Short data sheet** — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

### 16.3 Disclaimers

**General** — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such information.

**Right to make changes** — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

**Suitability for use** — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or

malfuction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

**Applications** — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

**Limiting values** — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

**Terms and conditions of sale** — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at <http://www.nxp.com/profile/terms>, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by NXP Semiconductors. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

**No offer to sell or license** — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

### 16.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

## 17. Contact information

For more information, please visit: <http://www.nxp.com>

For sales office addresses, please send an email to: [salesaddresses@nxp.com](mailto:salesaddresses@nxp.com)

## 18. Contents

<b>1</b>	<b>General description</b> .....	<b>1</b>
<b>2</b>	<b>Features</b> .....	<b>1</b>
<b>3</b>	<b>Ordering information</b> .....	<b>2</b>
<b>4</b>	<b>Marking</b> .....	<b>2</b>
<b>5</b>	<b>Functional diagram</b> .....	<b>2</b>
<b>6</b>	<b>Pinning information</b> .....	<b>3</b>
6.1	Pinning .....	3
6.2	Pin description .....	3
<b>7</b>	<b>Functional description</b> .....	<b>3</b>
<b>8</b>	<b>Limiting values</b> .....	<b>3</b>
<b>9</b>	<b>Recommended operating conditions</b> .....	<b>4</b>
<b>10</b>	<b>Static characteristics</b> .....	<b>4</b>
10.1	Test circuits .....	5
10.2	ON resistance .....	6
10.3	ON resistance test circuit and graphs.....	7
<b>11</b>	<b>Dynamic characteristics</b> .....	<b>9</b>
11.1	Waveforms and test circuit .....	10
11.2	Additional dynamic characteristics .....	11
11.3	Test circuits .....	13
<b>12</b>	<b>Application information</b> .....	<b>16</b>
<b>13</b>	<b>Package outline</b> .....	<b>17</b>
<b>14</b>	<b>Abbreviations</b> .....	<b>20</b>
<b>15</b>	<b>Revision history</b> .....	<b>20</b>
<b>16</b>	<b>Legal information</b> .....	<b>21</b>
16.1	Data sheet status .....	21
16.2	Definitions .....	21
16.3	Disclaimers .....	21
16.4	Trademarks .....	21
<b>17</b>	<b>Contact information</b> .....	<b>21</b>
<b>18</b>	<b>Contents</b> .....	<b>22</b>

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

founded by

**PHILIPS**

© NXP B.V. 2008.

All rights reserved.

For more information, please visit: <http://www.nxp.com>

For sales office addresses, please send an email to: [salesaddresses@nxp.com](mailto:salesaddresses@nxp.com)

Date of release: 3 July 2008

Document identifier: 74LVCV2G66\_2